

Notice of References Cited	Application/Control No. 10/613,070		Applicant(s)/Patent Under Reexamination TAKESHITA, HITOSHI	
	Examiner Luis F. Garcia		Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0145776	10-2002	Chow et al.	359/124
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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